# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

for the required fee.

Gurtei S. Sandhu

Group Art Unit: 1743

10/771,043

An itemized return postcard.

A Petition for Extension of Time for

Examiner:

month(s) and a check in the amount of \$

Yelena Gakh

Filed:

February 3, 2004

Docket No.:

150.01150103

Title:

<u>X</u>

Confirmation No.: 1538 DETECTION DEVICES, METHODS AND SYSTEMS FOR GAS PHASE MATERIALS

Commissioner for Patents Mail Stop Amendments P.O. Box 1450 Alexandria, VA 22313-1450

We are transmitting the following documents along with this Transmittal Sheet (which is submitted in triplicate):

copies of A check i A certifie claimed t Other:	mental Information 10 documents cited in the amount of \$ ed copy of a _ application application and a second conditions. No Additional control of the second condition and application application application application application and application applicati	on the 1449 forms, for cation, Serial No 9.	, filed	_, the right of prior	rity of which is
	Fee Calc	ulation for Claims	Pending After An	endment	
	Pending Claims after Amendment (1)	Claims Paid for Earlier (2)	Number of Additional Claims (1-2)	Cost per Additional Claim	Additional Fees Required
Total Claims				x \$18 =	
Independent Claims				x \$86 =	
One or M	fore New Multiple I	Dependent Claims P	resented? If Ves A	dd \$290 Here →	

Please consider this a PETITION FOR EXTENSION OF TIME for a sufficient number of months to enter these papers and please charge any additional fees or credit overpayment to Deposit Account No. 13-4895. Triplicate copies of this sheet are enclosed.

CERTIFICATE UNDER 37 C.F.R. §1.8: The undersigned hereby certifies that this Transmittal Letter and the paper(s), as described hereinabove, are being deposited in the United States Postal Service, as first class mail, in an envelope addressed to: Commissioner for Patents, Mail Stop Amendments, P.O. Box 1450, Alexandria, VA 22313-1450, on this **16+** day of **JUNE**, 2004.

MUETING, RAASCH & GEBHARDT, P.A.

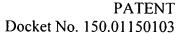
Customer Number: 26813

Kevin W. Raasch Reg. No.: 35,651

Direct Dial: 612-305-1218 Facsimile: 612-305-1228

Total Additional Claim Fees Required

(LARGE ENTITY TRANSMITTAL UNDER RULE 1.8)





## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s):	Gurtej S. Sandhu	)	Group Art Unit:	1743
Serial No.:	•	)	Examiner:	Yelena Gakh
Confirmation	No.: 1538	)		
Filed:	February 3, 2004	)		
For:	DETECTION DEVICES, MATERIALS	IETHOI	OS AND SYSTEMS	FOR GAS PHASE

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with C.F.R. §§ 1.97 *et. seq.*, the materials enclosed herewith are brought to the attention of the Examiner as possibly being of interest in connection with the above-identified patent application. Per M.P.E.P. § 609, the information cited in the present Information Disclosure Statement shall not be construed to be an admission that the information is, or is considered to be, material to patentability. Consideration of each of the documents listed on the attached 1449 form is respectfully requested. As this patent application was filed after June 30, 2003, copies of the U.S. patents and U.S. patent application publications listed on the attached 1449 form have not been submitted. Pursuant to the provisions of M.P.E.P. §609, Applicant further requests that a copy of the 1449 form, marked as being considered and initialed by the Examiner, be returned with the next Official Communication.

It is believed that no fee is due, as this Information Disclosure Statement is filed prior to the receipt of any Action on the merits. However, in the event a fee is due, please charge any fee or credit any overpayment to Account No. 13-4895.

Applicant(s): Gurtej S. Sandhu

Serial No.: 10/771,043 Confirmation No.:1538 Filed: February 3, 2004

For: DETECTION DEVICES, METHODS AND SYSTEMS FOR GAS PHASE MATERIALS

The Examiner is invited to contact Applicant's Representatives at the belowlisted telephone number, if they can be of any assistance during prosecution of the present application.

#### CERTIFICATE UNDER 37 C.F.R. 1.8:

The undersigned hereby certifies that this paper is being deposited in the United States Postal Service, as first class mail, in an envelope addressed to: Mail Stop Amendment, Commissioner for Patents. P.O. Box 1450. Alexandria, VA 22313-1450, on this **16t** day of JUNE, 2004.

Name: Kevin W. Raasch

JUNE 2004

Respectfully submitted for

### Gurtej S. Sandhu

By Mueting, Raasch & Gebhardt, P.A. P.O. Box 581415 Minneapolis, MN 55458-1415

Phone: (612)305-1220 Facsimile: (612)305-1228 **Customer Number 26813** 

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Atty. Docket No.: 150.01150103	Serial No.: 10/771,043
Applicant(s): Gurtej S. Sandhu	Confirmation No.: 1538
Application Filing Date: February 3, 2004	Group: 1743
Information Disclosure Statement mailed:	June <b>//</b> , 2004

## **U.S. PATENT DOCUMENTS**

Examiner Initial	Copy _Enclosed	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
		5,653,807	08/05/97	Crumbaker			

## **FOREIGN PATENT DOCUMENTS**

Examiner	Сору	Document Number	Date	Country	Class	Subclass	Translation	
Initial	Enclosed						Yes	No
	X	1,576,658	08/01/69	France (w/abstract)			X	
	X	2-293644	12/04/90	Japan (w/abstract)			X	
	X	3-48748	03/01/91	Japan (w/abstract)	-		X	
	X	2-69658	03/08/90	Japan (w/abstract)				X

OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)

Examiner Initial	Copy Enclosed	Document Description				
	X	Akinfieva, T.A., "Basis for the maximum allowable concentration of ruthenium dioxide in the air of work areas," <i>Gigiena Truda i Professional'nye Zabolevaniya</i> , 1981:46-47 (English Abstract Included)				
	X	Crawford et al., "Use of the Hazop Analysis for Evaluation of CVD reactors," Journal de Physique IV, September 1991: C2-459- C2-466.				
	X	Gale et al., "Interaction of Safety and the facility for Photovoltaic R & D,"  American Institute of Physics Conference Proceedings," 1988;66:145-151				
	X	Koda et al., "Radioactivation determination of ruthenium," Kyoto Daigaku Genshiro Jikkensho Gakujutsu Koenkai Koen Yoshishyu, 1976;10:25-27. (English Translation)				
	X	Lu et al., "Epitaxial growth of RuO <sub>2</sub> thin films by metal-organic chemical vapor deposition," <i>Thin Solid Films</i> , 1999;340:140-144.				
	X	Orlow et al., "Detection of Ruthenium in Platinum Alloys," <i>Chemiker-Zeitung</i> , 1908;32:77. (English Translation)				

EXAMINER	Date Considered	<u></u>

<sup>\*</sup>Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.